

**Notice of References Cited**

Application/Control No.

10/733,233

Applicant(s)/Patent Under  
Reexamination  
MIYAGAWA, YOSHIHIRO

Examiner

David E. Graybill

Art Unit

2822

Page 1 of 3

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,879,574 A	03-1999	Sivaramakrishnan et al.	216/60
*	B	US-5,935,334 A	08-1999	Fong et al.	118/723ME
*	C	US-5,935,340 A	08-1999	Xia et al.	134/1.1
*	D	US-6,019,848 A	02-2000	Frankel et al.	118/715
*	E	US-6,099,647 A	08-2000	Yieh et al.	118/697
*	F	US-6,114,216 A	09-2000	Yieh et al.	438/424
*	G	US-2001/0054387 A1	12-2001	Frankel et al.	118/725
*	H	US-6,348,099 B1	02-2002	Xia et al.	118/697
*	I	US-6,347,636 B1	02-2002	Xia et al.	134/1.1
*	J	US-6,352,591 B1	03-2002	Yieh et al.	118/697
*	K	US-2002/0073922 A1	06-2002	FRANKEL et al.	118/715
*	L	US-6,444,037 B1	09-2002	Frankel et al.	118/715
*	M	US-6,645,303 B2	11-2003	Frankel et al.	118/725

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

<b>Notice of References Cited</b>	Application/Control No. 10/733,233	Applicant(s)/Patent Under Reexamination MIYAGAWA, YOSHIHIRO	
	Examiner David E. Graybill	Art Unit 2822	Page 2 of 3

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,288,325 A	02-1994	Gomi, Hideki	118/692
*	B	US-5,763,286 A	06-1998	Figura et al.	438/255
*	C	US-5,812,403 A	09-1998	Fong et al.	700/121
*	D	US-5,849,635 A	12-1998	Akram et al.	438/704
*	E	US-5,939,831 A	08-1999	Fong et al.	315/111.21
*	F	US-5,963,840 A	10-1999	Xia et al.	438/783
*	G	US-5,968,587 A	10-1999	Frankel, Jonathan	427/8
*	H	US-5,994,209 A	11-1999	Yieh et al.	438/541
*	I	US-6,218,268 B1	04-2001	Xia et al.	438/435
*	J	US-6,333,277 B1	12-2001	Lin et al.	438/758
*	K	US-6,360,685 B1	03-2002	Xia et al.	118/723ME
*	L	US-6,376,303 B1	04-2002	Seo et al.	438/253
*	M	US-6,506,690 B1	01-2003	Lobbins, Jonathon M.	438/783

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

<b>Notice of References Cited</b>	Application/Control No. 10/733,233	Applicant(s)/Patent Under Reexamination MIYAGAWA, YOSHIHIRO	
	Examiner David E. Graybill	Art Unit 2822	Page 3 of 3

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,384,276 A	01-1995	Ogawa et al.	438/254
*	B	US-5,656,536 A	08-1997	Wu, Shye-Lin	438/397
*	C	US-5,716,884 A	02-1998	Hsue et al.	438/254
*	D	US-6,090,714 A	07-2000	Jang et al.	438/692
*	E	US-6,121,164 A	09-2000	Yieh et al.	438/790
*	F	US-6,239,002 B1	05-2001	Jang et al.	438/435
*	G	US-6,753,270 B1	06-2004	Geiger et al.	438/780
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.